



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: Unassigned Examiner: Unassigned

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Applicant(s): Nobuhisa KUMAMOTO et al.

Serial No: 10/767,439

Filed:

January 30, 2004

For:

SEMICONDUCTOR CHIP AND

PRODUCTION PROCESS

THEREFOR

Docket No.: Al 318D1

REQUEST TO CORRECT SUBMITTED FORM PTO-1449

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

This is a request to correct an error in one of the publication numbers entered on a Form PTO-1449 filed with an Information Disclosure Statement in the U.S. Patent and Trademark Office on April 27, 2005.

The third publication number under "Foreign Patent Documents" on the Form PTO-1449 indicates an incorrect number. The number should be corrected to read: **Number: 0813 238**. A new PTO-FORM-1449 is provided herewith correcting the error. Request for notification of the correction is requested.

Respectfully submitted,

May 26, 2005

Date

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SMR/pjl

FORM PTO-1449 TBADELLE				Atty Docket		Applicati	Application No.					
INFORMATION DISCLOSURE STATEMENT					AI 318D1	10	10/767,439					
				Applicant Nobuhisa KUMAMOTO et al.								
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U.S. PATENT DOCUMENTS												
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	Al	08-340029	12/24/96		PAN			YES				
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	AK	0813 238	12/17/97	7 EU	ROPE							
	AL	4-99537	08/27/92	JAF	PAN			NO				
	AM	7-42134	07/21/95	JAF	PAN			NO				
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EXAMINER:	Initial	if reference cons	idered, who	ether or n	ot citation is in conformand le copy of this form with ne	ce with MPEP 609	; draw line to Applica	e through ant.				